Supplementary information



Fig. S1 SEM micrographs of 4wt% R974 nano- SiO_2 particle filled 50/50 PP/PS blend after annealing at 190 °C for various time.





Fig. S2 Morphology evolution of 4wt% nano- SiO2 particle filled 50/50 PP/PS blend observed by an optical microscope during annealing at 190 °C.